

**Search Notes**

Application/Control No.

10/821,260

Examiner

Teena Mitchell

Applicant(s)/Patent under  
Reexamination

SNYDER ET AL.

Art Unit

3771

**SEARCHED**

Class	Subclass	Date	Examiner
128	200.23 203.15 203.19 203.21	5/17/2007	TKM
	203.12	5/17/2007	TKM
	200.14	5/17/2007	TKM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR